Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,626	HANAWA, HARUO
Examiner	Art Unit
Richard Schnizer, Ph. D.	1635

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	ARCH NOTE SEARCH S		)
		DATE	EXMR
STN		4/25/2000	RS
WEST		4/25/2007	RS
upďated		11/27/2007	RS
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